

**Notice of References Cited**Application/Control No.  
09/891,569Applicant(s)/Patent Under  
Reexamination  
WENZEL ET AL.Examiner  
Virginia M KiblerArt Unit  
2623

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| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Name          | Classification |
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|   | B | US-  |                 |               |                |
|   | C | US-  |                 |               |                |
|   | D | US-  |                 |               |                |
|   | E | US-  |                 |               |                |
|   | F | US-  |                 |               |                |
|   | G | US-  |                 |               |                |
|   | H | US-  |                 |               |                |
|   | I | US-  |                 |               |                |
|   | J | US-  |                 |               |                |
|   | K | US-  |                 |               |                |
|   | L | US-  |                 |               |                |
|   | M | US-  |                 |               |                |

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.